## Notice of References Cited

ı	Application/Control No. 09/626,347	Applicant(s)/Pater Reexamination DE HEER ET AL.		
	Examiner	Art Unit		
	PATRICK A. DARNO	2169	Page 1 of 1	

## U.S. PATENT DOCUMENTS

	C.C. TATENT DOCUMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,740,425	04-1998	Povilus, David S.	707/100
*	В	US-2003/0130905 A1	07-2003	Foster et al.	705/26
*	С	US-2003/0097211 A1	05-2003	Carroll et al.	701/33
*	D	US-6,182,275 B1	01-2001	Beelitz et al.	717/175
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	٦	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.